



RADIO TEST REPORT

Test Report No. : 10605030H-A-R1

Applicant : OMRON Automotive Electronics Co. Ltd.
Type of Equipment : Transmitter of Keyless Entry System
Model No. : J166N
Test regulation : FCC Part 15 Subpart C: 2015
FCC ID : OUCJ166N
Test Result : Complied

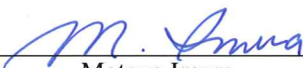
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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 10605030H-A. 10605030H-A is replaced with this report.

Date of test: January 5, 2015

Representative test engineer:


Masatoshi Nishiguchi
Engineer
Consumer Technology Division

Approved by:


Motoya Imura
Engineer
Consumer Technology Division



NVLAP LAB CODE: 200572-0

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UL Japan, Inc.
Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
Telephone : +81 596 24 8999
Facsimile : +81 596 24 8124

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SECTION 1: Customer information

Company Name : OMRON Automotive Electronics Co. Ltd.
Address : 6368 NENJOZAKA OKUSA KOMAKI AICHI, 485-0802 JAPAN
Telephone Number : +81-568-78-6159
Facsimile Number : +81-568-78-7659
Contact Person : Masashi Matsuda

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Transmitter of Keyless Entry System
Model No. : J166N
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 3.0V
Receipt Date of Sample : December 13, 2014
Country of Mass-production : Japan and Thailand
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: J166N (referred to as the EUT in this report) is the Transmitter of Keyless Entry System.

General Specification

Clock frequencies in the system : 2MHz, 9.844MHz

Radio Specification

Radio Type : Transmitter
Frequency of Operation : 315MHz
Modulation : FSK
Power Supply (radio part input) : DC 3.0V
Antenna type : Integral (Pattern Antena)

* The original model No.: J166N has variant models.
The differences of original model and variant models are only the number of switches and protocol.

Therefore, the test was performed with the representative original model which was the worst one.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2015, final revised on January 21, 2015
Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
and above 70MHz

* The revision on January 21, 2015 does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.4:2009 7. AC powerline conducted emission measurements ----- IC: RSS-Gen 8.8	FCC: Section 15.207 ----- IC: RSS-Gen 8.8	N/A	N/A*1)	-
Automatically Deactivate	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.231(a)(1) ----- IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators ----- IC: RSS-Gen 6.12	FCC: Section 15.231(b) ----- IC: RSS-210 A1.1.2	0.2dB 315.000MHz Horizontal PK with Duty factor	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators ----- IC: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) ----- IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 8.9	0.9dB 2520.000MHz Horizontal PK with Duty factor	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators ----- IC: -	FCC: Section 15.231(c) ----- IC: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 3.0V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 6.6	IC: RSS-210 A1.1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.0dB	5.1dB	5.0dB	5.1dB	6.0dB	4.9dB	4.3dB
No.2	3.9dB	5.2dB	5.0dB	4.9dB	5.9dB	4.7dB	4.2dB
No.3	4.3dB	5.1dB	5.2dB	5.2dB	6.0dB	4.8dB	4.2dB
No.4	4.6dB	5.2dB	5.0dB	5.2dB	6.0dB	5.7dB	4.2dB

*3m/1m/0.5m = Measurement distance

Radiated emission test(3m)

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

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Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

3.5 Test Location

UL Japan, Inc. Ise EMC Lab. *NVLAP Lab. code: 200572-0
 4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN
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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

Refer to APPENDIX.

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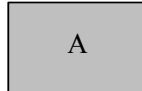
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 Facsimile : +81 596 24 8124

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate	Normal use mode
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20dB & 99% Occupied Bandwidth Duty Cycle	Continuous Transmitting mode
* The system was configured in typical fashion (as a customer would normally use it) for testing.	

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Transmitter of Keyless Entry System	J166N	B0001F *1) B0002F *2)	OMRON Automotive Electronics Co. Ltd.	EUT

*1) Used for Continuous Transmitting mode

*2) Used for Normal use mode

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 0.8m above the conducting ground plane. The EUT was set on the center of the tabletop. Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Photographs of the set up are shown in Appendix 3.

(Below 30MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3m.

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver/spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz	Above 1GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200Hz	200Hz	9.1kHz	9.1kHz	120kHz	PK: S/A:RBW 1MHz, VBW:3MHz

* For the test below 30MHz, the noise was not detected when it was confirmed with PK detect.

- The carrier level was measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9kHz-3.2GHz

Test data : APPENDIX

Test result : Pass

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Facsimile : +81 596 24 8124

SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX
Test result : Pass

SECTION 7: -20dB and 99% Occupied Bandwidth

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20dB Bandwidth	300kHz	3kHz	9.1kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 5% of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer

Peak hold was applied as Worst-case measurement.

Test data : APPENDIX
Test result : Pass

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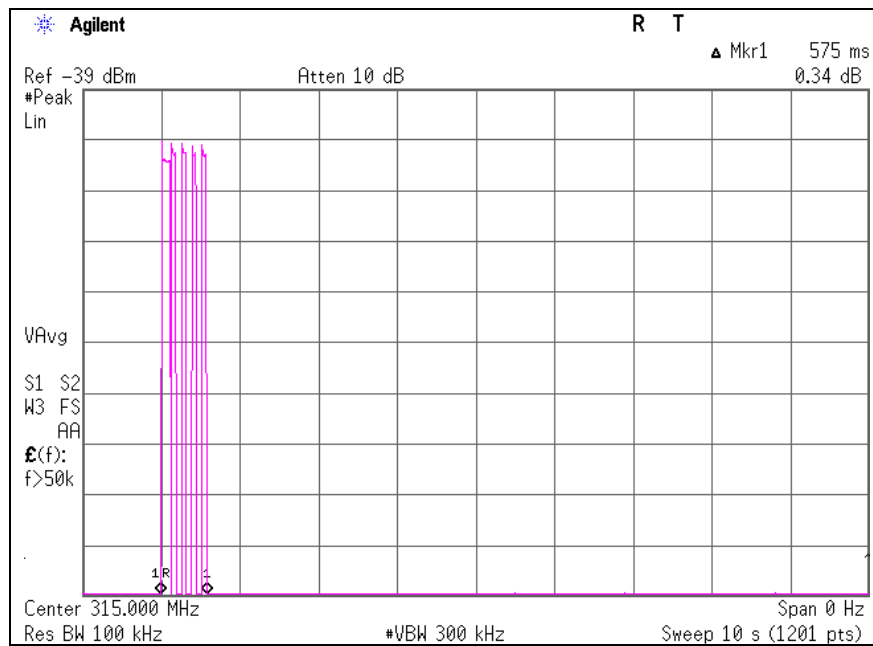
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APPENDIX 1: Test data

Automatically deactivate

Test place Ise EMC Lab. No.3 Semi Anechoic Chamber
 Report No. 10605030H
 Date 01/05/2015
 Temperature/ Humidity 25 deg. C / 32% RH
 Engineer Keisuke Kawamura
 Mode Normal use mode

Time of Transmitting [sec]	Limit [sec]	Result
0.575	5.00	Pass



Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Test place : Ise EMC Lab. No.3 Semi Anechoic Chamber
Report No. : 10605030H
Date : 01/05/2015
Temperature/ Humidity : 25 deg. C / 32% RH
Engineer : Keisuke Kawamura
Mode : Continuous Transmitting mode

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	82.1	78.3	15.1	10.1	31.9	-	75.4	71.6	95.6	20.2	24.0	Carrier
630.000	PK	51.7	50.7	19.8	12.0	32.0	-	51.5	50.5	75.6	24.1	25.1	Outside
945.000	PK	36.9	34.8	22.9	13.4	30.7	-	42.5	40.4	75.6	33.1	35.2	Outside
1260.000	PK	47.1	48.1	24.8	1.8	34.6	-	39.1	40.1	75.6	36.5	35.5	Outside
1575.000	PK	44.8	45.7	25.5	2.0	33.8	-	38.5	39.4	73.9	35.4	34.5	Inside
1890.000	PK	57.6	56.0	26.0	2.2	33.2	-	52.6	51.0	75.6	23.0	24.6	Outside
2205.000	PK	49.8	47.3	26.5	2.4	32.8	-	45.9	43.4	73.9	28.0	30.5	Inside
2520.000	PK	58.0	54.4	26.9	2.5	32.7	-	54.7	51.1	75.6	20.9	24.5	Outside
2835.000	PK	47.2	45.7	27.2	2.7	32.5	-	44.6	43.1	73.9	29.3	30.8	Inside
3150.000	PK	52.0	52.7	27.5	2.8	32.4	-	49.9	50.6	75.6	25.7	25.0	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit dBuV/m	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
315.000	PK	82.1	78.3	15.1	10.1	31.9	0.0	75.4	71.6	75.6	0.2	4.0	Carrier
630.000	PK	51.7	50.7	19.8	12.0	32.0	0.0	51.5	50.5	55.6	4.1	5.1	Outside
945.000	PK	36.9	34.8	22.9	13.4	30.7	0.0	42.5	40.4	55.6	13.1	15.2	Outside
1260.000	PK	47.1	48.1	24.8	1.8	34.6	0.0	39.1	40.1	55.6	16.5	15.5	Outside
1575.000	PK	44.8	45.7	25.5	2.0	33.8	0.0	38.5	39.4	53.9	15.4	14.5	Inside
1890.000	PK	57.6	56.0	26.0	2.2	33.2	0.0	52.6	51.0	55.6	3.0	4.6	Outside
2205.000	PK	49.8	47.3	26.5	2.4	32.8	0.0	45.9	43.4	53.9	8.0	10.5	Inside
2520.000	PK	58.0	54.4	26.9	2.5	32.7	0.0	54.7	51.1	55.6	0.9	4.5	Outside
2835.000	PK	47.2	45.7	27.2	2.7	32.5	0.0	44.6	43.1	53.9	9.3	10.8	Inside
3150.000	PK	52.0	52.7	27.5	2.8	32.4	0.0	49.9	50.6	55.6	5.7	5.0	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

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4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

-20dB and 99% Occupied Bandwidth

Test place	Ise EMC Lab. No.3 Semi Anechoic Chamber
Report No.	10605030H
Date	01/05/2015
Temperature/ Humidity	25 deg. C / 32% RH
Engineer	Keisuke Kawamura
Mode	Continuous Transmitting mode

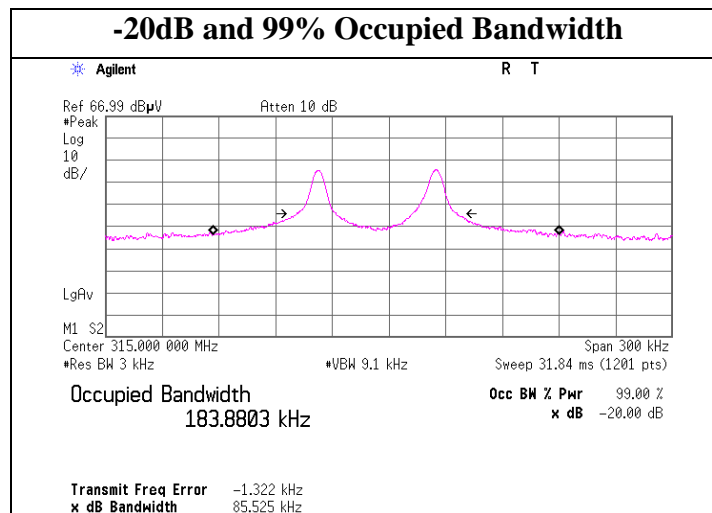
Bandwidth Limit : Fundamental Frequency **315 MHz** x 0.25% = 787.50 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
85.525	787.50	Pass

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
183.8803	787.50	Pass



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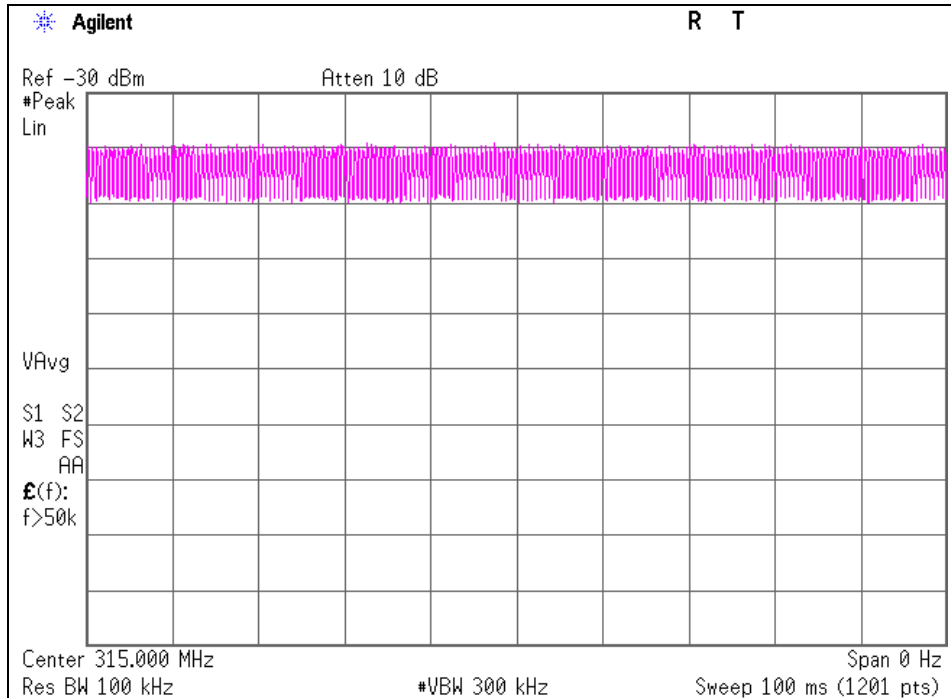
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Duty Cycle

Test place	Ise EMC Lab. No.3 Semi Anechoic Chamber
Report No.	10605030H
Date	01/05/2015
Temperature/ Humidity	25 deg. C / 32% RH
Engineer	Keisuke Kawamura
Mode	Continuous Transmitting mode

(Total)

ON time [ms]	Cycle [ms]	Duty (On time/Cycle)	Duty [dB]
100.000	100.00	1.0000	0.00



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APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-01	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	RE	2014/09/01 * 12
MOS-27	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	RE	2014/02/20 * 12
MJM-21	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-09	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	RE	2014/06/06 * 12
KBA-05	Biconical Antenna	Schwarzbeck	BBA9106	2513	RE	2014/11/22 * 12
KLA-04	Logperiodic Antenna	Schwarzbeck	USLP9143	361	RE	2014/11/22 * 12
MAT-08	Attenuator(6dB)	Weinschel Corp	2	BK7971	RE	2014/11/20 * 12
MCC-02	Coaxial Cable	Suhner/storm/Agilent/TSJ	-	-	RE	2014/09/12 * 12
MPA-19	Pre Amplifier	MITEQ	MLA-10K01-B01-35	1237616	RE	2014/02/17 * 12
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2014/02/27 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	1301	RE	2014/02/20 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE	-
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE	2014/08/19 * 12
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2014/10/18 * 12
MLA-03	Logperiodic Antenna	Schwarzbeck	USLP9143	174	RE	2014/10/18 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2014/07/14 * 12
MAT-70	Attenuator(6dB)	Agilent	8491A-006	MY52460153	RE	2014/04/14 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE	2014/03/14 * 12
MSA-16	Spectrum Analyzer	Agilent	E4440A	MY46186390	RE	2014/02/28 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2014/05/26 * 12
MCC-167	Microwave Cable	Junkosha	MWX221	1404S374(1m) / 1405S074(5m)	RE	2014/05/26 * 12
MPA-11	MicroWave System Amplifier	Agilent	83017A	MY39500779	RE	2014/03/24 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99% Occupied Bandwidth, -20dB bandwidth, Automatically deactivate and Duty cycle tests

UL Japan, Inc.

Ise EMC Lab.

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Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124